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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/683,904	10/10/2003	Daniel Alvarez JR.	7184-PA22A	3090	
21005 7	21005 7590 07/21/2004			EXAMINER	
HAMILTON, BROOK, SMITH & REYNOLDS, P.C. 530 VIRGINIA ROAD			CARRILLO, BIBI SHARIDAN		
	P.O. BOX 9133 CONCORD, MA 01742-9133			PAPER NUMBER	
CONCORD, N					
			DATE MAILED: 07/21/2004	1	

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)			
	10/683,904	ALVAREZ ET AL.			
Office Action Summary	Examiner	Art Unit			
	Sharidan Carrillo	1746			
The MAILING DATE of this communication Period for Reply	appears on the cover sheet w	vith the correspondence address			
A SHORTENED STATUTORY PERIOD FOR RE THE MAILING DATE OF THIS COMMUNICATIO - Extensions of time may be available under the provisions of 37 CFF after SIX (6) MONTHS from the mailing date of this communication - If the period for reply specified above is less than thirty (30) days, a - If NO period for reply is specified above, the maximum statutory per - Failure to reply within the set or extended period for reply will, by st Any reply received by the Office later than three months after the mearned patent term adjustment. See 37 CFR 1.704(b).	N. R 1.136(a). In no event, however, may a reply within the statutory minimum of thi riod will apply and will expire SIX (6) MO atute, cause the application to become A	reply be timely filed rty (30) days will be considered timely. NTHS from the mailing date of this communication. BANDONED (35 U.S.C. § 133).			
Status					
1)⊠ Responsive to communication(s) filed on 1	0 October 2003.				
	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.				
Disposition of Claims					
4)⊠ Claim(s) <u>1-11</u> is/are pending in the applicat 4a) Of the above claim(s) is/are without 5)□ Claim(s) is/are allowed. 6)⊠ Claim(s) <u>1-11</u> is/are rejected. 7)□ Claim(s) is/are objected to. 8)□ Claim(s) are subject to restriction and	drawn from consideration.				
Application Papers					
9)⊠ The specification is objected to by the Exam					
10) The drawing(s) filed on is/are: a) a					
Applicant may not request that any objection to Replacement drawing sheet(s) including the cor	= • •	` ,			
11) The oath or declaration is objected to by the					
Priority under 35 U.S.C. § 119					
<u> </u>	inna main aite con des 05 H 0 0	0.440() (1) (0			
12) Acknowledgment is made of a claim for fore a) All b) Some * c) None of: 1. Certified copies of the priority docum 2. Certified copies of the priority docum 3. Copies of the certified copies of the papplication from the International Bur * See the attached detailed Office action for a	ents have been received. ents have been received in A priority documents have been reau (PCT Rule 17.2(a)).	Application No received in this National Stage			
* See the attached detailed Office action for a	list of the certified copies not	received.			
Attachment(s)	_				
1) ⊠ Notice of References Cited (PTO-892) 2) ☑ Notice of Draftsperson's Patent Drawing Review (PTO-948)		Summary (PTO-413) s)/Mail Date			
 Rotice of Draitsperson's Patent Drawing Review (PTO-948) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/Paper No(s)/Mail Date 		Informal Patent Application (PTO-152)			

DETAILED ACTION

Specification

1. The disclosure is objected to because of the following informalities: Applicant is requested to update the specification to include the serial number for the related case as recited in paragraph 1 of the specification.

Appropriate correction is required.

Claim Rejections - 35 USC § 112

2. The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

3. Claims 6 and 7 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

In claim 6, the device lacks positive antecedent basis. In claim 7, the term "nobel" is spelled incorrectly.

Claim Rejections - 35 USC § 103

- 4. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 5. The factual inquiries set forth in *Graham* v. *John Deere Co.*, 383 U.S. 1, 148 USPQ 459 (1966), that are applied for establishing a background for determining obviousness under 35 U.S.C. 103(a) are summarized as follows:

1. Determining the scope and contents of the prior art.

2. Ascertaining the differences between the prior art and the claims at issue.

3. Resolving the level of ordinary skill in the pertinent art.

- 4. Considering objective evidence present in the application indicating obviousness or nonobviousness.
- 6. This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).
- 7. Claims 1-4, 6-8 and 10 are rejected under 35 U.S.C. 103(a) as being unpatentable over Spiegelman et al. (6638341) in view of Kern (Handbook of Semiconductor Wafer Cleaning, 1993, pages 88-89).

In reference to claims 1, 8, and 10, Spiegelman et al. teach preconditioning a substrate by purging with a purging gas in order to removing packing gas from the substrate within the vessel. Spiegelman et al. further teach repeating the cycle for as many times as needed in order to remove substantially all packing gas within the substrate (col. 3, lines 45-50, col. 4, lines 1-7). Spiegelman et al. teach preconditioning the substrate for subsequent decontamination of a contaminated gas which includes hydrogen, oxygen, nitrogen, air, and argon (col. 4, lines 60-65). In reference to claim 1, Spiegelman et al. teach decontaminating the contaminated gas until the concentration

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of contaminants is on the order of 1-1000pppt (col. 8, claim 17). Speigelman et al. do not teach the purge gas comprising water. Spiegelman et al. teach gases such as oxygen.

Kern teaches that both ultrapure nitrogen and oxygen contain contaminants such as water. It would have been obvious to a skilled artisan to have modified the method of Spiegelman et al. to include water in the purge gas since Kern teaches that ultrapure nitrogen and oxygen include small concentrations of contaminants such as water.

In reference to claims 2-4, refer to col. 5, lines 25-27. In reference to claims 6 and 7, the limitations are met since Speigelman et al. teach repeating the purge cycle as many times as needed and further teaches gases such as nitrogen and argon.

8. Claim 5 is rejected under 35 U.S.C. 103(a) as being unpatentable over Spiegelman et al. (6638341) in view of Kern (Handbook of Semiconductor Wafer Cleaning Technology, 1993, pages 88-89), as applied to claims 1-4, 6-8 and 10 as described in paragraph 7 above, and further in view of Alvarez Jr. et al. (6391090).

Spiegelman et al. in view of Kern fail to teach the limitations of claim 5. Alvarez Jr. et al. teach that gases such as He, nitrogen, and oxygen has water contamination levels in the rage of 10-100ppm. In view of the teachings of Alvarez, one would reasonably expect the oxygen purge gas of Spiegelman et al. to have water contamination levels in the range of 10-100ppm.

9. Claims 1-5, 8 and 10-11 are rejected under 35 U.S.C. 103(a) as being unpatentable over Somekh (6427703) in view of Alvarez Jr. et al. (6391090).

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In reference to claims 1, 8, and 10-11, Somekh teaches purging a lithography chamber with pure oxygen gas to remove carbon contamination (Figs. 2a, 4) and removing the contamination with a vacuum pump (col. 5, lines 35-40, col. 6, lines 20-25). Somekh fails to teach purified gases having a concentration level of less than 1ppb.

Alvarez Jr. et al. teach purification of gases used in photolithography in order to reduce the contamination level to 1ppb or lower (col. 7, lines 7-10, col. 8, lines 15-17) such that molecular contaminants on the optical components of the lithography tool is reduced.

It would have been obvious to a person of ordinary skill in the art to have modified the method of Somekh to include purification of the lens gases, as taught by Alvarez such that contaminants in the optical components can be avoided.

In reference to claim 2, refer to col. 8, line 7 of Alvarez.

In reference to claims 3-4, Somekh in view of Alvarez fail to teach the specified limitations. However, it would have been within the level of the skilled artisan to reduce the contamination level in the lens gases in order to further reduce contaminants present on the optical components of the lithography equipment. In reference to claim 5, refer to col. 7, line 66 of Alvarez et al.

10. Claims 6-7 are rejected under 35 U.S.C. 103(a) as being unpatentable over Somekh (6427703) in view of Alvarez et al. (6391090), as applied to claims 1-5, 8 and 10-11 as described in paragraph 9 above, and further in view of Van Schaik et al. (6724460).

Somekh in view of Alvarez fail to teach purging with an inert gas. Van Schaik et al. teach in-situ cleaning of optical components for use in a lithographic apparatus. In col. 4, lines 1-22, Van Scheik teach purging with nitrogen. It would have been obvious to a person of ordinary skill in the art to have modified the method of Somekh to include purging with an inert gas, since Van Schaik et al. teach it is conventional to purge with an inert gas in order to remove contaminants from the lithographic apparatus.

11. Claim 9 is rejected under 35 U.S.C. 103(a) as being unpatentable over Somekh (6427703) in view of Alvarez et al. (6391090), as applied to claims 1-5, 8 and 10-11 as described in paragraph 9 above, and further in view of Straaijer et al. (5602683).

Somekh in view of Alvarez fail to teach the limitations of claim 9. Somekh teaches purging with oxygen but fails to teach the concentration. Straaijer et al. teach using oxygen gas having a concentration of 1 percent per volume for purposes of cleaning a lens system to remove contaminants. It would have been obvious to the skilled artisan to have modified the method of Somekh to include adjusting the concentration of oxygen as taught by Straaijer et al., for purposes of removing contaminants from the lens chamber.

Double Patenting

12. The nonstatutory double patenting rejection is based on a judicially created doctrine grounded in public policy (a policy reflected in the statute) so as to prevent the unjustified or improper timewise extension of the "right to exclude" granted by a patent and to prevent possible harassment by multiple assignees. See *In re Goodman*, 11 F.3d 1046, 29 USPQ2d 2010 (Fed. Cir. 1993); *In re Longi*, 759 F.2d 887, 225 USPQ 645 (Fed. Cir. 1985); *In re Van Ornum*, 686 F.2d 937, 214 USPQ 761 (CCPA 1982); *In re Vogel*, 422 F.2d 438, 164 USPQ 619 (CCPA 1970);and, *In re Thorington*, 418 F.2d 528, 163 USPQ 644 (CCPA 1969).

A timely filed terminal disclaimer in compliance with 37 CFR 1.321(c) may be used to overcome an actual or provisional rejection based on a nonstatutory double

patenting ground provided the conflicting application or patent is shown to be commonly owned with this application. See 37 CFR 1.130(b).

Effective January 1, 1994, a registered attorney or agent of record may sign a terminal disclaimer. A terminal disclaimer signed by the assignee must fully comply with 37 CFR 3.73(b).

13. Claims 1-11 are provisionally rejected under the judicially created doctrine of obviousness-type double patenting as being unpatentable over claims 1-19 of copending Application No. 10/683903. Although the conflicting claims are not identical, they are not patentably distinct from each other because the claims are directed to the removal of airborne contaminants from a surface and purifying a purge gas.

This is a <u>provisional</u> obviousness-type double patenting rejection because the conflicting claims have not in fact been patented.

14. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. Bonora et al. teach a method of cleaning a pod using ultrapure nitrogen. Van Schaik et al. teach a lithographic projection apparatus. Brunemeier et al. teach a plasma-flash process. Shamouilian et al. teach purging with oxygen and nitrogen gas. Brooks et al. teach cleaning articles. Mulkens et al. teach purging with nitrogen.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Sharidan Carrillo whose telephone number is 571-272-1297. The examiner can normally be reached on Monday-Friday, 6:00a.m-2:30pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Michael Barr can be reached on 571-272-1414. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

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SHARIDAN CARRILLO PRIMARY EXAMINER